



ISOFACE™

ISO1H811G

Galvanic Isolated 8 Channel High-Side Switch

Datasheet

Revision 2.5, 2014-10-17

Power Management & Multimarket

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**Revision History**

Page or Item	Subjects (major changes since previous revision)
<b>Revision 2.5, 2014-10-17</b>	
Page 4	Feature list updated, Vbb Monitoring included
Page 7	Page 7 Chapter 2 Block diagram updated
Page 9	Page 9 Chapter 3.3.3 Description for repetitive short circuit corrected
Page 9	Page 9 Chapter 3.4 Vbb Monitoring included in common diagnostic output description
Page 14	Page 14 Chapter 4.4 V <sub>ISO</sub> changed to correct value ΔV <sub>ISO</sub> = 500V
Page 15	Page 15 Chapter 4.5 Footnotes corrected
Page 16	Page 16 Chapter 4.8 Timing parameter for CS delay split into t <sub>CSD</sub> and t <sub>CSDMD</sub>
Page 17	Page 17 Chapter 4.10 Parameter Minimum Internal Gap removed
all	Correction of formats and typos
<b>Revision 2.4</b>	
Page 12	Page 12 table 4.1 Extended operating temperature footnote removed
<b>Revision 2.0</b>	
all	Final Datasheet

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## Coreless Transformer Isolated Digital Output 8 Channel 0.625 A High-Side Switch

### Product Highlights

- Coreless transformer isolated data interface
- Galvanic isolation
- 8 High-side output switches 0.625A
- µC compatible 8-bit parallel peripheral



### Features

- Interface 3.3/5V CMOS operation compatible
- Parallel interface
- Direct control mode
- High common mode transient immunity
- Short circuit protection
- Maximum current internally limited
- Overload protection
- Overtoltage protection (including load dump)
- Undervoltage shutdown with autorestart and hysteresis
- Switching inductive loads
- Common output disable pin
- Thermal shutdown with restart
- Thermal independence of separate channels
- Common diagnostic output
- ESD protection
- Loss of GND<sub>bb</sub> and loss of V<sub>bb</sub> protection
- Reverse Output Voltage protection
- Isolated return path for DIAG signal
- V<sub>bb</sub> monitoring
- UL508 / RoHS compliant

### Typical Application

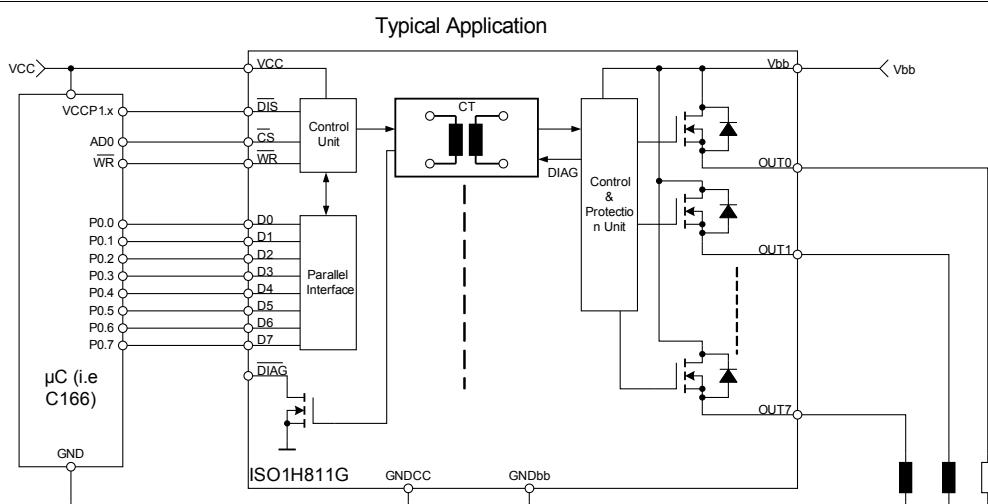
- Isolated switch for industrial applications (PLC)
- All types of resistive, inductive and capacitive loads
- µC compatible power switch for 24V DC applications
- Driver for solenoid, relays and resistive loads

### Description

The ISO1H811G is a galvanically isolated 8 bit data interface in PG-DSO-36 package that provides 8 fully protected high-side power switches that are able to handle currents up to 625 mA.

An 8 bit parallel µC compatible interface allows to connect the IC directly to a µC system. The input interface supports also a direct control mode and is designed to operate with 3.3/5V CMOS compatible levels.

The data transfer from input to output side is realized by the integrated Coreless Transformer Technology.

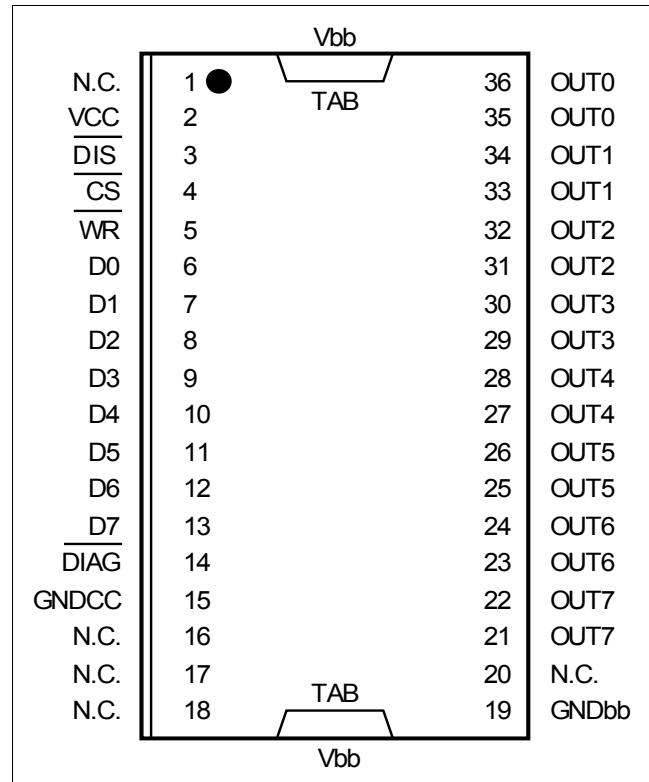


Type		On-state Resistance	Package
ISO1H811G		200mΩ	PG-DSO36

## 1 Pin Configuration and Functionality

### 1.1 Pin Configuration

Pin	Symbol	Function
1	N.C.	Not connected
2	VCC	Positive 3.3/5V logic supply
3	<u>DIS</u>	Output disable
4	<u>CS</u>	Chip select
5	<u>WR</u>	Parallel write
6	D0	Data input bit0
7	D1	Data input bit1
8	D2	Data input bit2
9	D3	Data input bit3
10	D4	Data input bit4
11	D5	Data input bit5
12	D6	Data input bit6
13	D7	Data input bit7
14	<u>DIAG</u>	Common diagnostic output
15	GNDCC	Input logic ground
16	N.C.	Not connected
17	N.C.	Not connected
18	N.C.	Not connected
19	GNDbb	Output driver ground
20	N.C	Not connected
21	OUT7	High-side output of channel 7
22	OUT7	High-side output of channel 7
23	OUT6	High-side output of channel 6
24	OUT6	High-side output of channel 6
25	OUT5	High-side output of channel 5
26	OUT5	High-side output of channel 5
27	OUT4	High-side output of channel 4
28	OUT4	High-side output of channel 4
29	OUT3	High-side output of channel 3
30	OUT3	High-side output of channel 3
31	OUT2	High-side output of channel 2
32	OUT2	High-side output of channel 2
33	OUT1	High-side output of channel 1
34	OUT1	High-side output of channel 1
35	OUT0	High-side output of channel 0
36	OUT0	High-side output of channel 0
TAB	Vbb	Positive driver power supply voltage



**Figure 1 Power SO-36 (430mil)**

## 1.2 Pin Functionality

### VCC (Positive 3.3/5V logic supply)

The VCC supplies the input interface that is galvanically isolated from the output driver stage. The input interface can be supplied with 3.3/5V.

### DIS (Output disable)

The high-side outputs OUT0...OUT7 can be immediately switched off by means of the low active pin DIS that is an asynchronous signal. The input registers are also reset by the DIS signal. The Output remains switched off after low-high transition of DIS signal, till new information is written into the input register. Current Sink to GNDCC.

### CS (Chip select)

The system microcontroller selects the ISO1H811G by means of the low active pin CS to activate the parallel interface. By connecting the CS pin and WR pin to ground the parallel direct control is activated. Current Source to VCC.

### WR (Parallel write)

In parallel mode data at the input pins (D0 ... D7) are latched by means of the rising edge of the low active signal WR (write). Current Source to VCC.

### D0 ... D7 (Data input bit0 ... bit7)

The present data can be latched on the rising edge of the write signal WR. D0 ... D7 control the corresponding output channels OUT0 ...OUT7. By connecting CS and WR to ground, the signals at D0 ... D7 directly control the outputs. Current Sink to GNDCC.

### DIAG (Common diagnostic output)

The low active DIAG signal contains the OR-wired information of the separated overtemperature detection units for each channel. The output pin DIAG provides an open drain functionality. A current source is also connected to the pin DIAG. In normal operation the signal DIAG is high. When overtemperature or Vbb below ON-Limit is detected the signal DIAG changes to low.

### GNDCC (Ground for VCC domain)

This pin acts as the ground reference for the input interface that is supplied by VCC.

### GNDbb (Output driver ground domain)

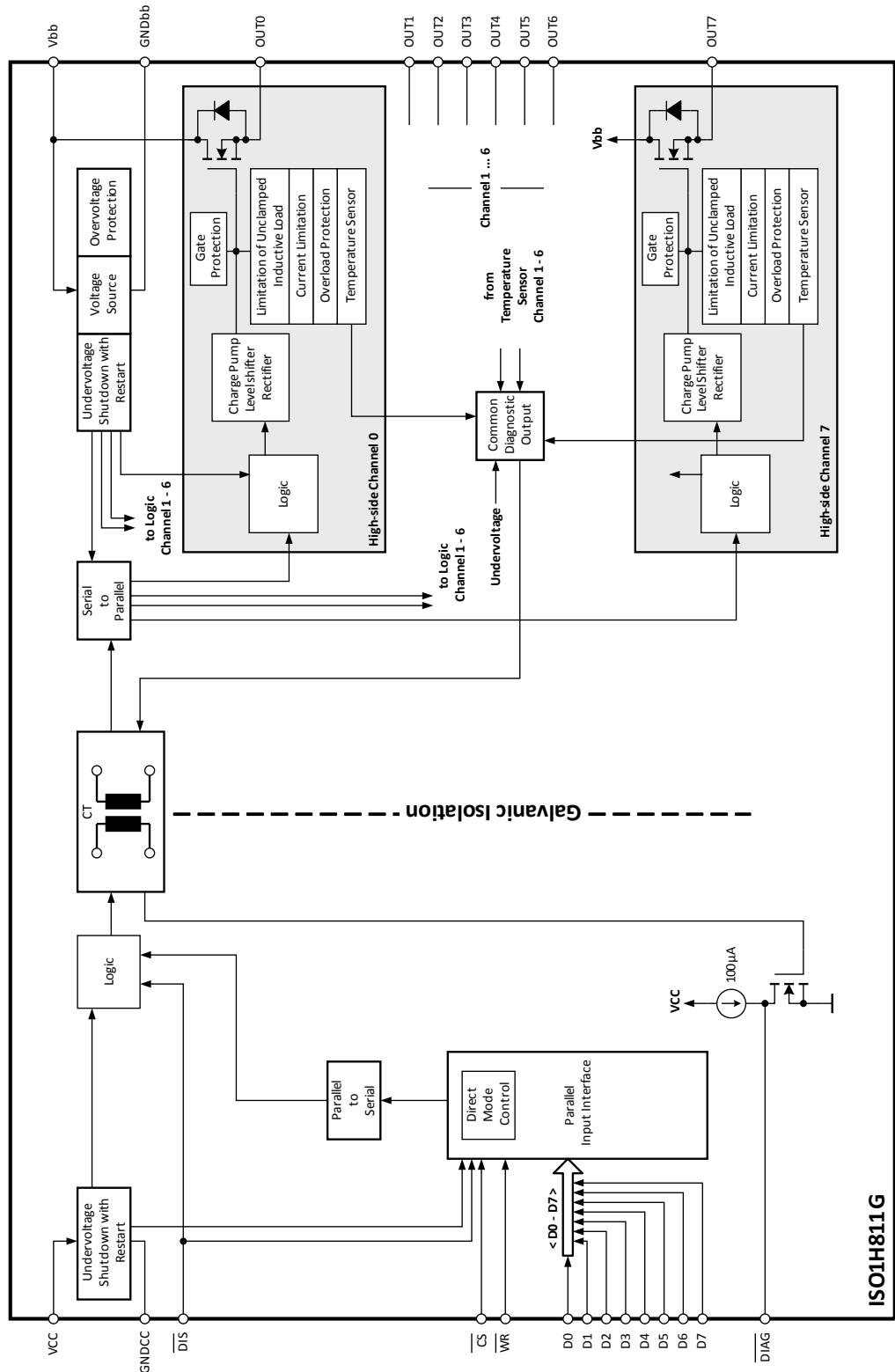
This pin acts as the ground reference for the output driver that is supplied by Vbb.

### OUT0 ... OUT7 (High side output channel 0 ... 7)

The output high side channels are internally connected to Vbb and controlled by the corresponding data input pins D0 ... D7 in parallel mode.

### TAB (Vbb, Positive supply for output driver)

The heatslug is connected to the positive supply port of the output interface.

**2**
**Blockdiagram**

**Figure 2 Blockdiagram**

## 3 Functional Description

### 3.1 Introduction

The ISOFACE ISO1H811G includes 8 high-side power switches that are controlled by means of the integrated parallel interface. The interface is 8bit µC compatible. Furthermore a direct control mode can be selected that allows the direct control of the outputs OUT0...OUT7 by means of the inputs D0...D7 without any additional logic signal. The IC can replace 8 optocouplers and the 8 high-side switches in conventional I/O-Applications as a galvanic isolation is implemented by means of the integrated coreless transformer technology. The µC compatible interface allows a direct connection to the ports of a microcontroller without the need for other components. Each of the 8 high-side power switches is protected against short to V<sub>bb</sub>, overload, overtemperature and against overvoltage by an active zener clamp.

The diagnostic logic on the power chip recognizes the overtemperature information of each power transistor. The information is send via the internal coreless transformer to the pin DIAG at the input interface.

### 3.2 Power Supply

The IC contains 2 galvanic isolated voltage domains that are independent from each other. The input interface is supplied at V<sub>CC</sub> and the output stage is supplied at V<sub>bb</sub>. The different voltage domains can be switched on at different time. The output stage is only enabled once the input stage enters a stable state.

### 3.3 Output Stage

Each channel contains a high-side vertical power FET that is protected by embedded protection functions.

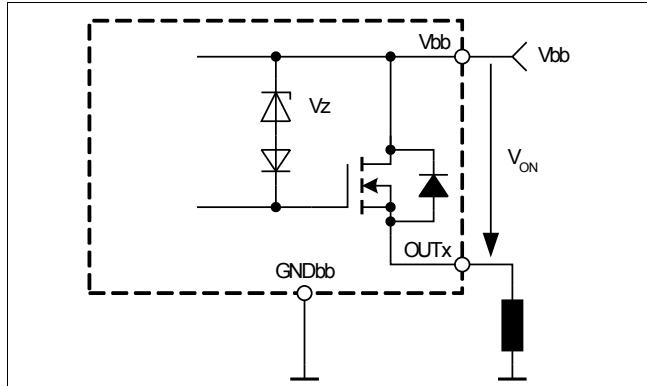
The continuous current for each channel is 625mA (all channels ON).

#### 3.3.1 Output Stage Control

Each output is independently controlled by an output latch and a common reset line via the pin  $\overline{DIS}$  that disables all eight outputs and resets the latches. The parallel input data is transferred to the input latches with a high-to-low transition of the signal  $\overline{WR}$  (write) while the  $\overline{CS}$  is logic low. A low-to-high transition of  $\overline{CS}$  transfers then the data of the input latches to the output buffer.

#### 3.3.2 Power Transistor Overvoltage Protection

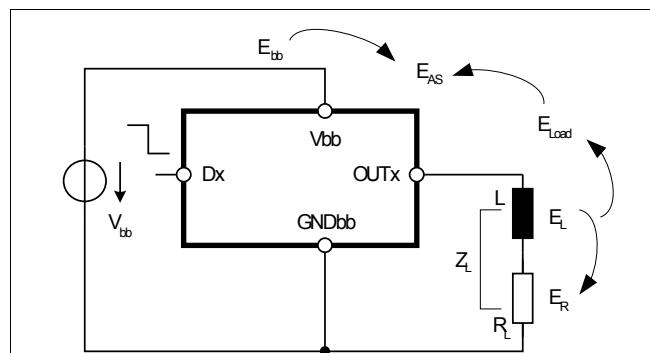
Each of the eight output stages has its own zener clamp that causes a voltage limitation at the power transistor when solenoid loads are switched off. V<sub>ON</sub> is then clamped to 47V (min.).



**Figure 3 Inductive and overvoltage output clamp (each channel)**

Energy is stored in the load inductance during an inductive load switch-off.

$$E_L = 1/2 \times L \times I_L^2$$



**Figure 4 Inductive load switch-off energy dissipation (each channel)**

While demagnetizing the load inductance, the energy dissipation in the DMOS is

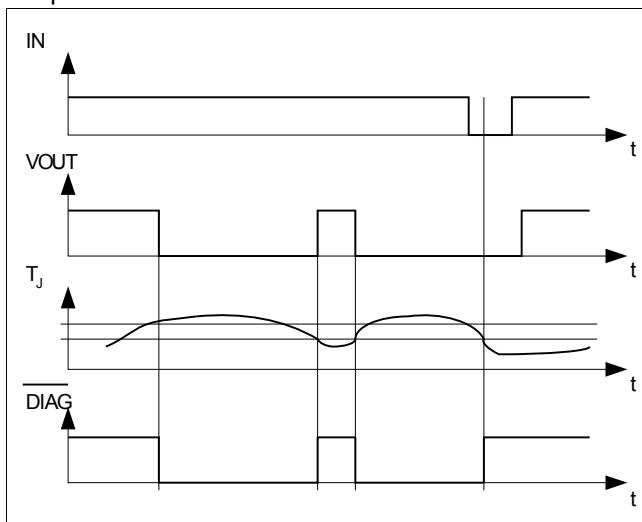
$$E_{AS} = E_{bb} + E_L - E_R = V_{ON(CL)} \times i_L(t) dt$$

with an approximate solution for  $R_L > 0\Omega$ :

$$E_{AS} = \frac{I_L \times L}{2 \times R_L} \times (V_{bb} + |V_{ON(CL)}|) \times \ln\left(1 + \frac{I_L \times R_L}{|V_{ON(CL)}|}\right)$$

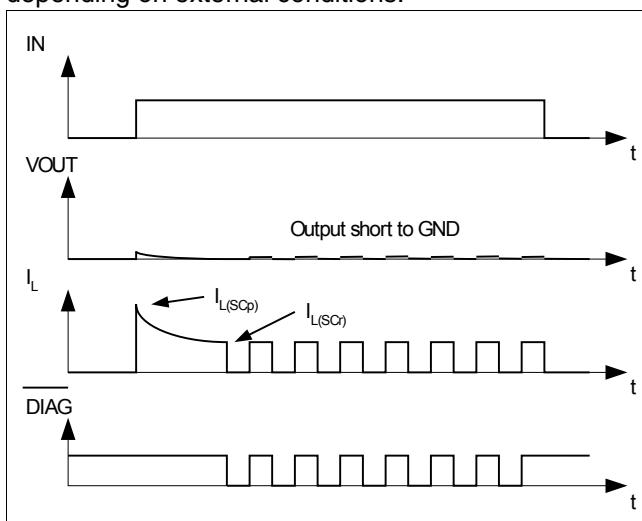
### 3.3.3 Power Transistor Overcurrent Protection

The outputs are provided with a current limitation that enters a repetitive switched mode after an initial peak current has been exceeded. The initial peak short circuit current limit is set to  $I_{L(SCp)}$ . During the repetitive short circuit the current limit is set to  $I_{L(SCr)}$ . If this operation leads to an overtemperature condition, a second protection level ( $T_j > 135^\circ\text{C}$ ) will change the output into a low duty cycle PWM (selective thermal shutdown with restart) to prevent critical chip temperatures.

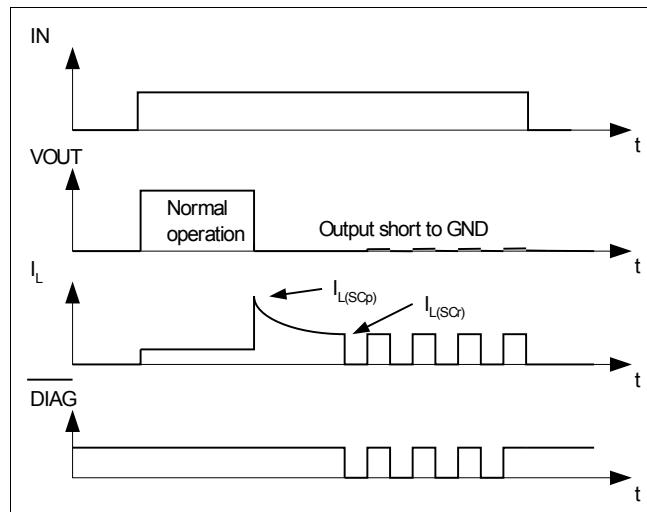


**Figure 5** Overttemperature detection

The following figures show the timing for a turn on into short circuit and a short circuit in on-state. Heating up of the chip may require several milliseconds, depending on external conditions.



**Figure 6** Turn on into short circuit, shut down by overtemperature, restart by cooling

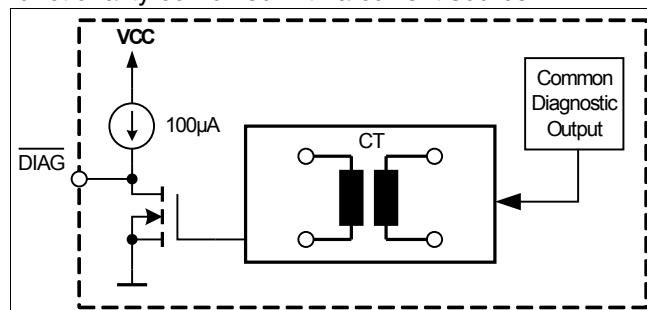


**Figure 7** Short circuit in on-state, shut down by overtemperature, restart by cooling

### 3.4 Common Diagnostic Output

The overtemperature detection information are OR-wired in the common diagnostic output block. The information is send via the integrated coreless transformer to the input interface. In addition Vbb undervoltage is indicated at the DIAG output.

The output stage at pin DIAG has an open drain functionality combined with a current source.



**Figure 8** Common diagnostic output

### 3.5 Parallel Interface

The ISO1H811G contains a parallel interface that can be directly controlled by the microcontroller output ports. The parallel interface can also be switched over to a direct control that allows direct changes of the outputs OUT0 ... OUT7 by means of the corresponding inputs D0 ... D7 without additional logic signals. To activate the parallel direct control mode pin **CS** and pin **WR** have to be connected both to ground.

#### 3.5.1 Parallel Interface Signal Description

**CS** - Chip select. The system microcontroller selects the ISO1H811G by means of the **CS** pin. Whenever the pin is in a logic low state, data can be transferred from the **μC**.

**CS** High to low transition:

- Parallel input data can be written in from then on

**CS** Low to high transition:

- The data in the input latches is transferred to the output buffer

**WR** - Write. The system controller enables the write procedure in the ISO1H811G by means of the signal **WR**. A logic low state signal at pin **WR** writes the input data into the input latches when the **CS** pin is in a logic low state.

**WR** Logic low level:

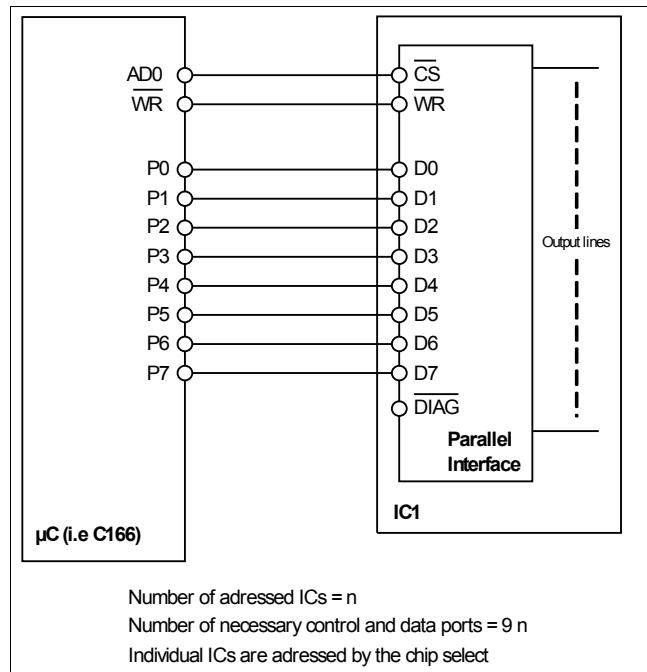
- Parallel input data at the pins D0 - D7 is written into the input latches

**WR** Logic high level:

- The parallel input data is latched in the input latches. Any changes at the pins D0 - D7 after the low-to-high transition of **WR** do not affect the input latches.

**D0 ... D7** - Parallel input. Parallel data bits are fed into the pins D0 ... D7. The data is written into the input latches when **WR** is logic low.

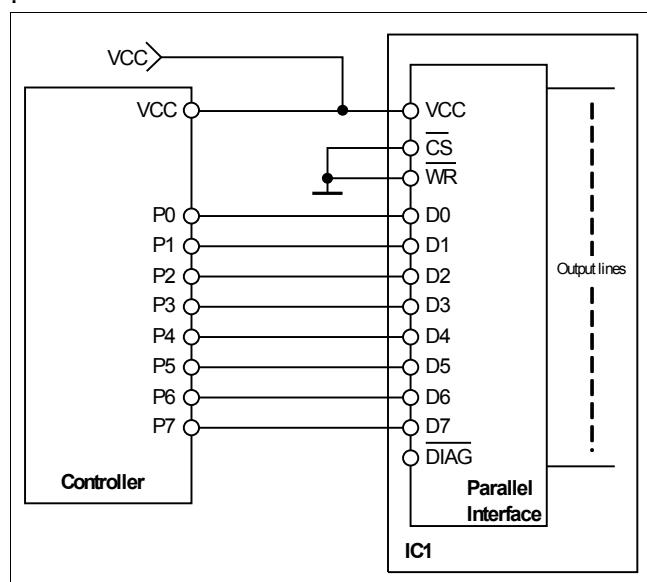
#### 3.5.2 uC Control Mode



**Figure 9** Parallel bus configuration

#### 3.5.3 Direct Control Mode

Beside the use of the parallel **μC** compatible interface a parallel direct control mode can be chosen. In this mode the output OUT0...OUT7 can be directly controlled via the inputs D0...D7 without the need for additional logic signals. To activate this mode pin **CS** and **WR** need to be connected to ground.



**Figure 10** Parallel Direct Control

### 3.6 Parallel Interface Timing

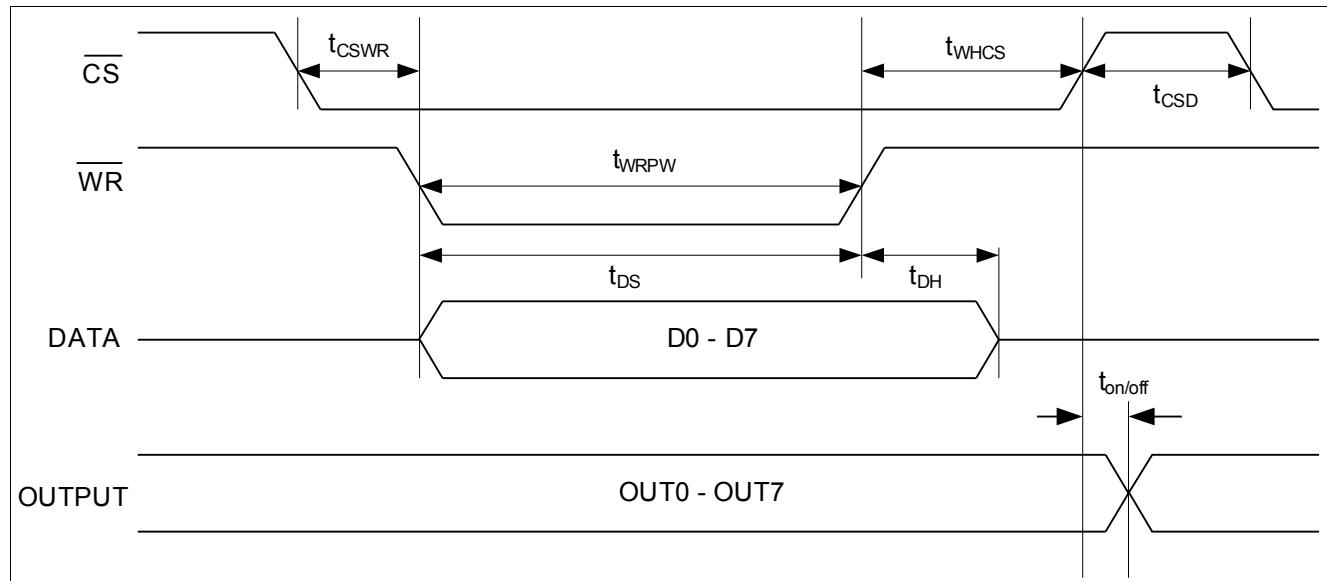


Figure 11 Parallel input - output timing diagram

### 3.7 Transmission Failure Detection

There is a failure detection unit integrated to ensure also a stable functionality during the integrated coreless transformer transmission. This unit decides whether the transmitted data is valid or not. If four times serial data coming in from the internal registers is not accepted, the output stages are switched off until the next valid data is received. (see also table 4.3)

## 4 Electrical Characteristics

Note: All voltages at pins 2 to 14 are measured with respect to ground GNDCC (pin 15). All voltages at pin 20 to pin 36 and TAB are measured with respect to ground GNDbb (pin 19). The voltage levels are valid if other ratings are not violated. The two voltage domains  $V_{CC}$  and  $V_{bb}$  are internally galvanically isolated.

### 4.1 Absolute Maximum Ratings

Note: Absolute maximum ratings are defined as ratings, which when being exceeded may lead to destruction of the integrated circuit. For the same reason make sure, that any capacitor that will be connected to pin 2 ( $V_{CC}$ ) and TAB ( $V_{bb}$ ) is discharged before assembling the application circuit. Supply voltages higher than  $V_{bb(AZ)}$  require an external current limit for the GNDbb pin, e.g. with a  $15\Omega$  resistor in GNDbb connection. Operating at absolute maximum ratings can lead to a reduced lifetime.

Parameter	Symbol	Limit Values		Unit
		min.	max.	
at $T_j = -40 \dots 135^\circ\text{C}$ , unless otherwise specified				
Supply voltage input interface ( $V_{CC}$ )	$V_{CC}$	-0.5	6.5	
Supply voltage output interface ( $V_{bb}$ )	$V_{bb}$	-1 <sup>1)</sup>	45	
Continuos voltage at data inputs (D0 ... D7)	$V_{DX}$	-0.5	6.5	
Continuos voltage at pin $\overline{CS}$	$V_{CS}$	-0.5	6.5	
Continuos voltage at pin $\overline{WR}$	$V_{WR}$	-0.5	6.5	
Continuos voltage at pin $\overline{DIS}$	$V_{DIS}$	-0.5	6.5	
Continuos voltage at pin $\overline{DIAG}$	$V_{DIAG}$	-0.5	6.5	
Load current (short-circuit current)	$I_L$	—	self limited	A
Reverse current through GNDbb <sup>1)</sup>	$I_{GNDbb}$	-1.6	—	
Operating Temperature	$T_j$	-25	internal limited	
Extended Operation Temperature	$T_j$	-40	internal limited	
Storage Temperature	$T_{stg}$	-50	150	
Power Dissipation <sup>2)</sup>	$P_{tot}$	—	3.3	W
Inductive load switch-off energy dissipation <sup>3)</sup> single pulse, $T_j = 125^\circ\text{C}$ , $I_L = 0.625\text{A}$ one channel active all channel simultaneously active (each channel)	$E_{AS}$	— — — —	— — 10 1	J
Load dump protection <sup>3)</sup> $V_{loadDump}^{4)} = V_A + V_S$ $V_{IN}$ = low or high $t_d = 400\text{ms}$ , $R_L = 2\Omega$ , $R_L = 27\Omega$ , $V_A = 13.5\text{V}$ $t_d = 350\text{ms}$ , $R_L = 2\Omega$ , $R_L = 57\Omega$ , $V_A = 27\text{V}$	$V_{loadDump}$	— — — —	— — 90 117	V
Electrostatic discharge voltage (Human Body Model) according to JESD22-A114-B	$V_{ESD}$	—	2	kV
Electrostatic discharge voltage (Charge Device Model) according to ESD STM5.3.1 - 1999	$V_{ESD}$	—	1	kV
Continuos reverse drain current <sup>1)</sup> <sup>3)</sup> , each channel	$I_S$	—	4	A

1) defined by  $P_{tot}$

2) Device on 50mm\*50mm\*1.5mm epoxy PCB FR4 with 6cm<sup>2</sup> (one layer, 70 $\mu\text{m}$  thick) copper area for drain connection. PCB is vertical without blown air.

3) not subject to production test, specified by design

4)  $V_{loadDump}$  is setup without the DUT connected to the generator per ISO7637-1 and DIN40839

## 4.2 Thermal Characteristics

<b>Parameter</b> at $T_j = -25 \dots 125^\circ\text{C}$ , $V_{bb}=15\dots30\text{V}$ , $V_{CC}=3.0\dots5.5\text{V}$ , unless otherwise specified	<b>Symbol</b>	<b>Limit Values</b>			<b>Unit</b>	<b>Test Condition</b>
		<b>min.</b>	<b>typ.</b>	<b>max.</b>		
Thermal resistance junction - case	$R_{thJC}$	—	—	1.5	<b>K/W</b>	
Thermal resistance @ min. footprint	$R_{th(JA)}$	—	—	50		
Thermal resistance @ 6cm <sup>2</sup> cooling area <sup>1)</sup>	$R_{th(JA)}$	—	—	38		

1) Device on 50mm\*50mm\*1.5mm epoxy PCB FR4 with 6cm<sup>2</sup> (one layer, 70 $\mu\text{m}$  thick) copper area for drain connection. PCB is vertical without blown air.

## 4.3 Load Switching Capabilities and Characteristics

<b>Parameter</b> at $T_j = -25 \dots 125^\circ\text{C}$ , $V_{bb}=15\dots30\text{V}$ , $V_{CC}=3.0\dots5.5\text{V}$ , unless otherwise specified	<b>Symbol</b>	<b>Limit Values</b>			<b>Unit</b>	<b>Test Condition</b>
		<b>min.</b>	<b>typ.</b>	<b>max.</b>		
On-state resistance, $I_L = 0.5\text{A}$ , each channel $T_j = 25^\circ\text{C}$ $T_j = 125^\circ\text{C}$ two parallel channels, $T_j = 25^\circ\text{C}$ : <sup>1)</sup> four parallel channels, $T_j = 25^\circ\text{C}$ : <sup>1)</sup>	$R_{ON}$	— —	150 270 75 38	200 320 100 50	$\text{m}\Omega$	
Nominal load current Device on PCB 38K/W, $T_a = 85^\circ\text{C}$ , $T_j < 125^\circ\text{C}$ one channel: <sup>1)</sup> two parallel channels: <sup>1)</sup> four parallel channels: <sup>1)</sup>	$I_{L(NOM)}$		0.7 1.1 2.2		$\text{A}$	
Turn-on time to 90% $V_{OUT}$ <sup>2)</sup> $R_L = 47\Omega$ , $V_{Dx} = 0$ to $5\text{V}$	$t_{on}$	—	64	120	$\mu\text{s}$	
Turn-off time to 10% $V_{OUT}$ <sup>2)</sup> $R_L = 47\Omega$ , $V_{Dx} = 5$ to $0\text{V}$	$t_{off}$	—	89	170		
Slew rate on 10 to 30% $V_{OUT}$ $R_L = 47\Omega$ , $V_{bb} = 15\text{V}$	$dV/dt_{on}$	—	1	2	$\text{V}/\mu\text{s}$	
Slew rate off 70 to 40% $V_{OUT}$ $R_L = 47\Omega$ , $V_{bb} = 15\text{V}$	$-dV/dt_{off}$	—	1	2		
Internal data transmission period	$t_{idt}$			17,8	$\mu\text{s}$	<sup>1)</sup>
Failure shutdown time	$t_{fs}$			64	$\mu\text{s}$	<sup>1)</sup>

1) not subject to production test, specified by design

2) The turn-on and turn-off time includes the switching time of the high-side switch and the transmission time via the coreless transformer in normal operating mode. During a failure on the coreless transformer transmission turn-on or turn-off time can increase by up to 50 $\mu\text{s}$ .

#### 4.4 Operating Parameters

<b>Parameter</b> at $T_j = -25 \dots 125^\circ\text{C}$ , $V_{bb}=15\dots30\text{V}$ , $V_{CC}=3.0\dots5.5\text{V}$ , unless otherwise specified	<b>Symbol</b>	<b>Limit Values</b>			<b>Unit</b>	<b>Test Condition</b>
		<b>min.</b>	<b>typ.</b>	<b>max.</b>		
Common mode transient immunity <sup>1)</sup>	$\Delta V_{ISO}/dt$	-25	-	25	$\text{kV}/\mu\text{s}$	$\Delta V_{ISO} = 500\text{V}$
Magnetic field immunity <sup>1)</sup>	$H_{IM}$	100			$\text{A}/\text{m}$	IEC61000-4-8
Voltage domain $V_{bb}$ (Output interface)	Operating voltage	$V_{bb}$	11	—	35	V
	Undervoltage shutdown	$V_{bb(\text{under})}$	7	—	10.5	
	Undervoltage restart	$V_{bb(\text{u\_rst})}$	—	—	11	
	Undervoltage hysteresis	$\Delta V_{bb(\text{under})}$	—	0.5	—	
	Undervoltage current	$I_{bb(\text{uvlo})}$	—	1	2.5	
	Operating current	$I_{GNDL}$	—	10	14	
	Leakage output current (included in $I_{bb(\text{off})}$ ) $V_{Dx} = \text{low}$ , each channel	$I_{L(\text{off})}$	—	5	30	$\mu\text{A}$
Voltage domain $V_{CC}$ (Input interface)	Operating voltage	$V_{CC}$	3.0	—	5.5	V
	Undervoltage shutdown	$V_{CC(\text{under})}$	2.5	—	2.9	
	Undervoltage restart	$V_{CC(\text{u\_rst})}$	—	—	3	
	Undervoltage hysteresis	$\Delta V_{CC(\text{under})}$	—	0.1	—	
	Undervoltage current	$I_{CC(\text{uvlo})}$	—	1	2	
	Operating current	$I_{CC(\text{on})}$	—	4.5	6	

1) not subject to production test

## 4.5 Output Protection Functions

Parameter <sup>1)</sup> at $T_j = -25 \dots 125^\circ\text{C}$ , $V_{bb}=15\dots30\text{V}$ , $V_{CC}=3.0\dots5.5\text{V}$ , unless otherwise specified	Symbol	Limit Values			Unit	Test Condition		
		min.	typ.	max.				
Initial peak short circuit current limit, each channel: $T_j = -25^\circ\text{C}$ , $V_{bb} = 30\text{V}$ , $t_m = 700\mu\text{s}$ $T_j = 25^\circ\text{C}$ $T_j = 125^\circ\text{C}$	$I_{L(SCP)}$	—	—	1.9	A			
		—	1.4	—				
		0.7	—	—				
Repetitive short circuit current limit $T_j = T_{jt}$ (see timing diagrams)	$I_{L(SCR)}$	twice the current of one channel						
		four times the current of one channel						
		—	—	—				
Output clamp (inductive load switch off) <sup>3)</sup> at $V_{OUT} = V_{bb} - V_{ON(CL)}$	$V_{ON(CL)}$	47	53	60	V			
		—	—	—				
		—	—	—				
Overvoltage protection	$V_{bb(AZ)}$	47	—	—				
Thermal overload trip temperature <sup>2)4)</sup>	$T_{jt}$	135	—	—	°C			
Thermal hysteresis <sup>2)</sup>	$\Delta T_{jt}$	—	10	—	K			

- Integrated protection functions are designed to prevent IC destruction under fault conditions described in the data sheet. Fault conditions are considered as "outside" normal operating range. Protection functions are not designed for continuous repetitive operation.
- not subject to production test, specified by design
- If channels are connected in parallel, output clamp is usually accomplished by the channel with the lowest  $V_{ON(CL)}$
- Higher operating temperature at normal function for each channel available

## 4.6 Diagnostic Characteristics at pin $\overline{DIAG}$

Parameter at $T_j = -25 \dots 125^\circ\text{C}$ , $V_{bb}=15\dots30\text{V}$ , $V_{CC}=3.0\dots5.5\text{V}$ , unless otherwise specified	Symbol	Limit Values			Unit	Test Condition
		min.	typ.	max.		
Common diagnostic sink current (overtemperature of any channel) $T_j = 135^\circ\text{C}$	$I_{diagsink}$	—	—	5	mA	$V_{diagon} < 0.25 \times V_{CC}$
Common diagnostic source current	$I_{diagsource}$	—	100	—	μA	

## 4.7 Input Interface

<b>Parameter</b> at $T_j = -25 \dots 125^\circ\text{C}$ , $V_{bb}=15\dots30\text{V}$ , $V_{CC}=3.0\dots5.5\text{V}$ , unless otherwise specified	<b>Symbol</b>	<b>Limit Values</b>			<b>Unit</b>	<b>Test Condition</b>
		<b>min.</b>	<b>typ.</b>	<b>max.</b>		
Input low state voltage (D0 ... D7, DIS, CS, WR)	$V_{IL}$	-0.3	—	$0.3 \times V_{CC}$	V	
Input high state voltage (D0 ... D7, DIS, CS, WR)	$V_{IH}$	$0.7 \times V_{CC}$	—	$V_{CC} + 0.3$		
Input voltage hysteresis (D0 ... D7, DIS, CS, WR)	$V_{IHys}$		100		mV	
Input pull down current (D0 ... D7, DIS)	$I_{Idown}$		100		$\mu\text{A}$	
Input pull up current (CS, WR)	$-I_{Iup}$		100			
Output disable time (transition DIS to logic low) <sup>1)2)</sup> Normal operation Turn-off time to 10% $V_{OUT}$ $R_L = 47\Omega$	$t_{DIS}$	---	85	170	$\mu\text{s}$	
Output disable time (transition DIS to logic low) <sup>1)2)3)</sup> Disturbed operation Turn-off time to 10% $V_{OUT}$ $R_L = 47\Omega$	$t_{DIS}$	---	---	230		

- 1) The time includes the turn-on/off time of the high-side switch and the transmission time via the coreless transformer.
- 2) If Pin DIS is set to low the outputs are set to low; after DIS set to high a new write cycle is necessary to set the output again.
- 3) The parameter is not subject to production test - verified by design/characterization

## 4.8 Parallel Interface Input Timing

<b>Parameter</b> at $T_j = -25 \dots 125^\circ\text{C}$ , $V_{bb}=15\dots30\text{V}$ , $V_{CC}=3.0\dots5.5\text{V}$ , unless otherwise specified	<b>Symbol</b>	<b>Limit Values</b>			<b>Unit</b>	<b>Test Condition</b>
		<b>min.</b>	<b>typ.</b>	<b>max.</b>		
WR pulse width	$t_{WRPW}$	20	—	—	ns	
Data setup time before WR	$t_{DS}$	20	—	—		
Data hold time after WR	$t_{DH}$	10	—	—		
Chip select valid to WR	$t_{CSWR}$	0	—	—		
WR logic high to CS logic high	$t_{WHCS}$	10	—	—		
Delay to next CS cycle	$t_{CSD}$	10	—	—		
Delay to next CS cycle for multiple device synchronization <sup>1)</sup>	$t_{CSDMD}$	17.8			$\mu\text{s}$	<sup>2)</sup>
Input to output data transmission jitter in direct mode <sup>1)</sup>	$t_{IOJ}$	8		17.8		<sup>2)</sup>

- 1) necessary CS delay time to ensure a proper data update for multiple devices
- 2) not subject to production test, specified by design

#### 4.9 Reverse Voltage

<b>Parameter</b> at $T_j = -25\ldots 125^\circ\text{C}$ , $V_{bb}=15\ldots 30\text{V}$ , $V_{CC}=3.0\ldots 5.5\text{V}$ , unless otherwise specified	<b>Symbol</b>	<b>Limit Values</b>			<b>Unit</b>	<b>Test Condition</b>
		<b>min.</b>	<b>typ.</b>	<b>max.</b>		
Reverse voltage <sup>1)</sup> <sup>2)</sup> $R_{GND} = 0 \Omega$ $R_{GND} = 150 \Omega$	$-V_{bb}$	—	—	1 45	V	
Diode forward on voltage $IF = 1.25\text{A}$ , $V_{Dx} = \text{low}$ , each channel	$-V_{ON}$	—	—	1.2		

1) defined by  $P_{tot}$

2) not subject to production test, specified by design

#### 4.10 Isolation and Safety-Related Specification

<b>Parameter</b>	<b>Value</b>	<b>Unit</b>	<b>Conditions</b>
Measured from input terminals to output terminals, unless otherwise specified			
Rated dielectric isolation voltage $V_{ISO}$	500	$V_{AC}$	1 - minute duration <sup>1)</sup>
Short term temporary overvoltage	1250	V	5s acc. DIN EN60664-1 <sup>1)</sup>
Minimum external air gap (clearance)	2.6	mm	shortest distance through air.
Minimum external tracking (creepage)	2.6	mm	shortest distance path along body.

1) not subject to production test, verified by characterization; Production Test with 1100V, 100ms duration

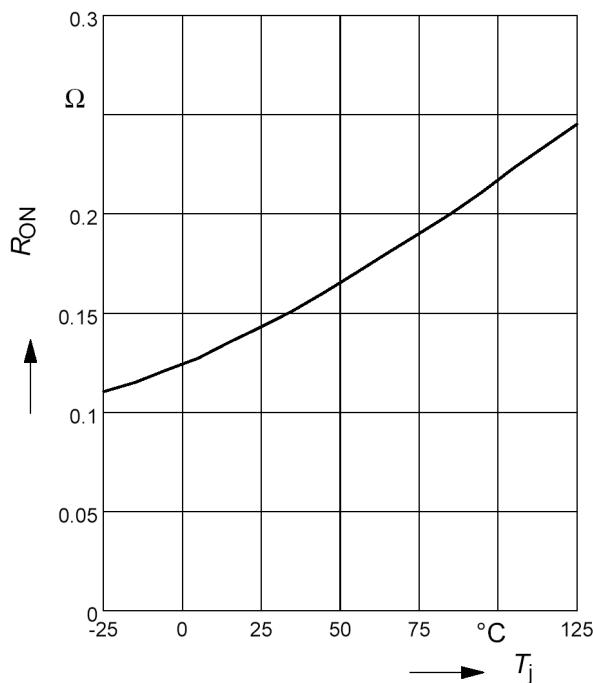
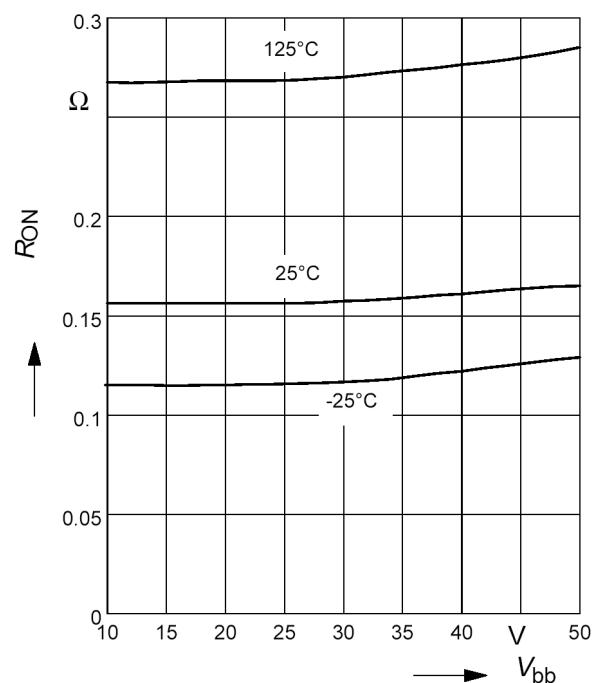
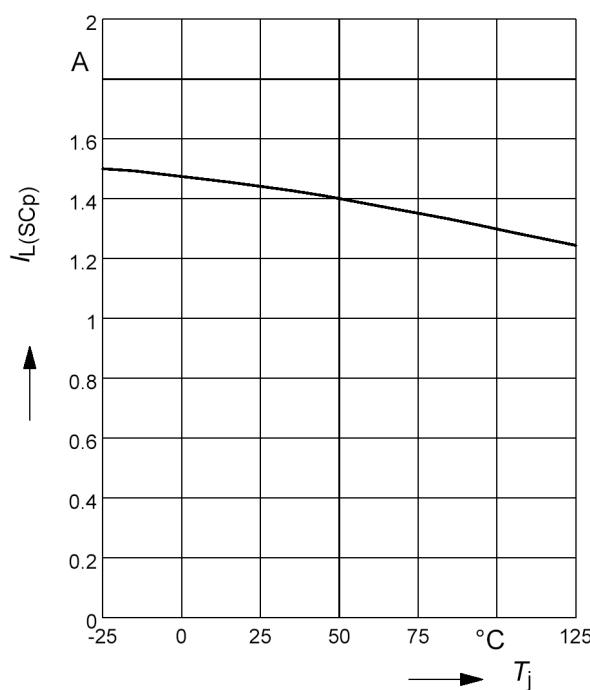
#### Approvals:

UL508, CSA C22.2 NO.14

Certificate Number: 20090514-E329661

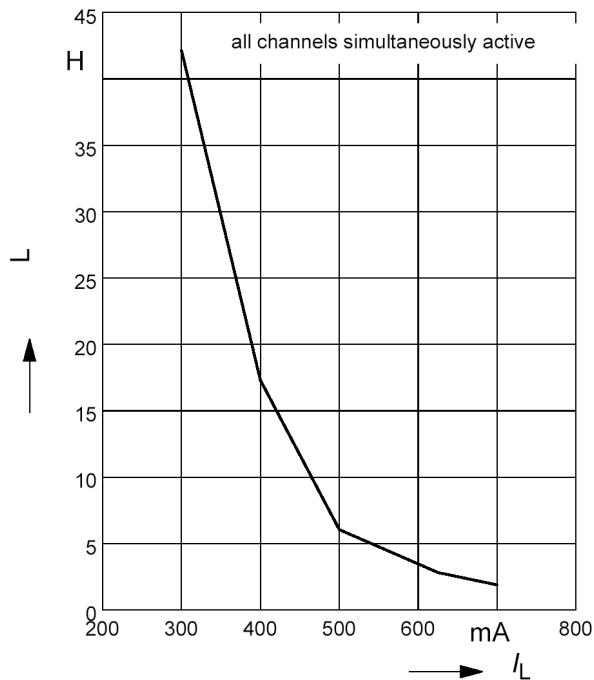
#### 4.11 Reliability

For Qualification Report please contact your local Infineon Technologies office!

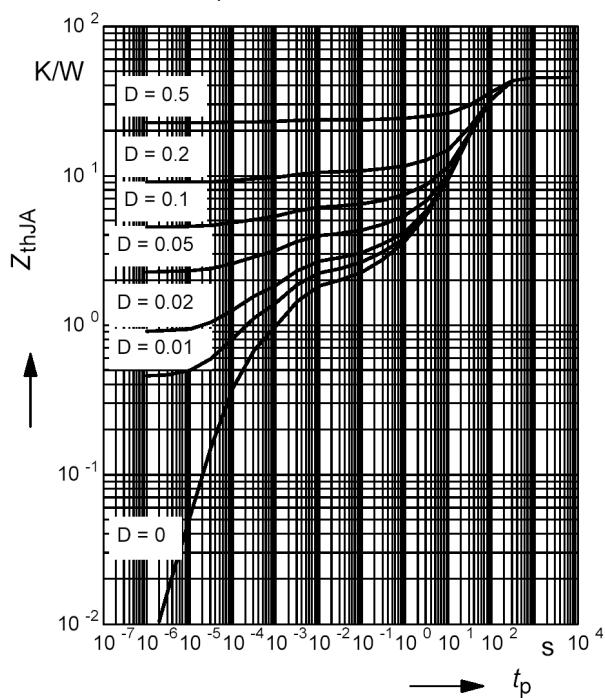
**Typ. on-state resistance**
 $R_{ON} = f(T_j)$  ;  $V_{bb} = 15V$  ;  $V_{in} = \text{high}$ 

**Typ. on-state resistance**
 $R_{ON} = f(V_{bb})$ ;  $I_L = 0.5A$  ;  $V_{in} = \text{high}$ 

**Typ. initial peak short circuit current limit**
 $I_{L(SCP)} = f(T_j)$  ;  $V_{bb} = 24V$ 


**Maximum allowable load inductance**
**for a single switch off, calculated**

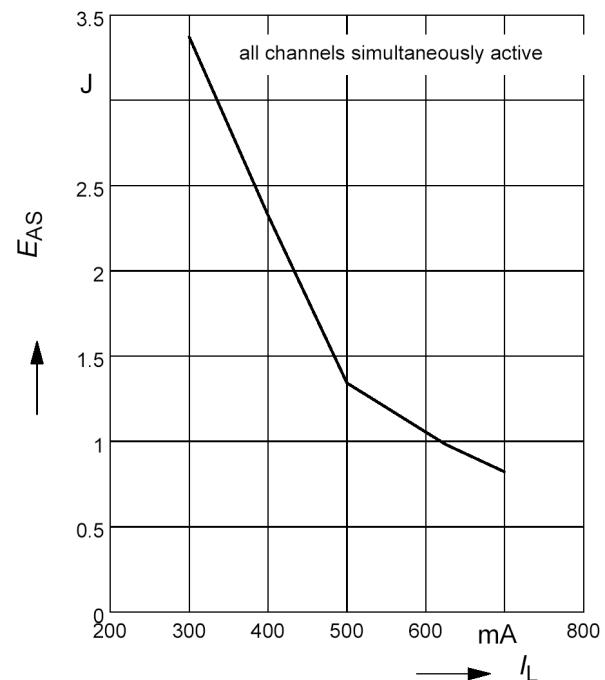
$$L = f(I_L); T_{jstart} = 125^\circ\text{C}, V_{bb} = 24\text{V}, R_L = 0\Omega$$


**Typ. transient thermal impedance**

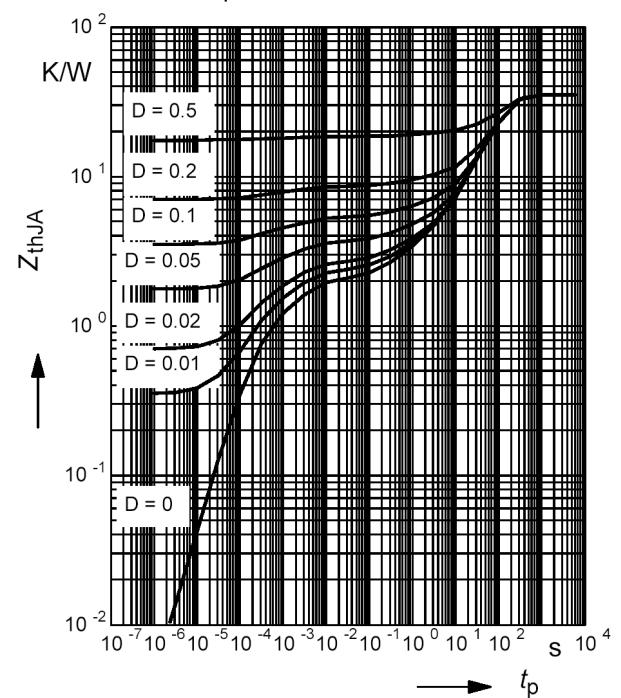
$$Z_{thJA} = f(t_p) \text{ @ min. footprint}$$

 Parameter:  $D = t_p/T$ 

**Maximum allowable inductive switch-off energy, single pulse**

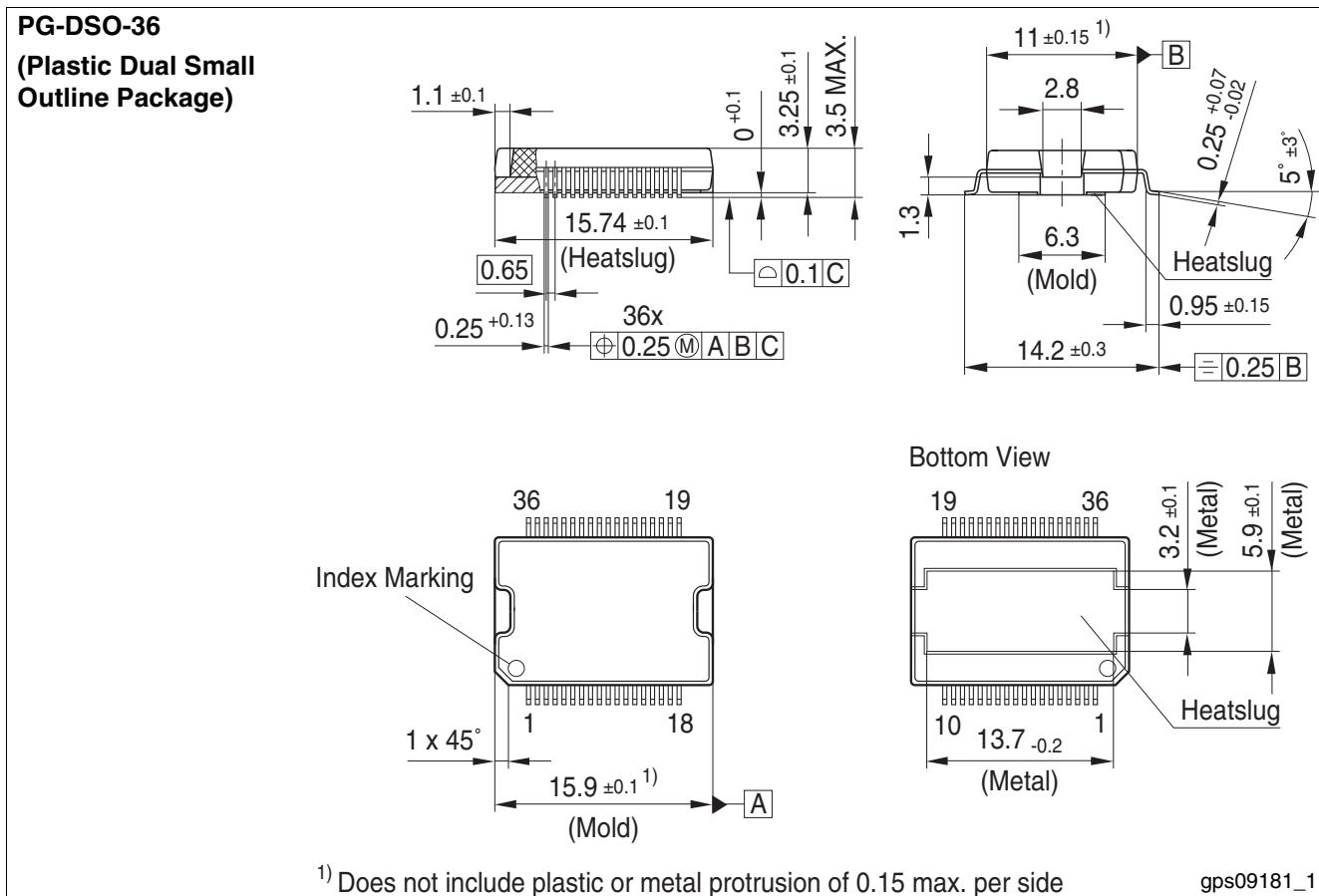
$$E_{AS} = f(I_L); T_{jstart} = 125^\circ\text{C}, V_{bb} = 24\text{V}$$


**Typ. transient thermal impedance**

$$Z_{thJA} = f(t_p) \text{ @ } 6\text{cm}^2 \text{ heatsink area}$$

 Parameter:  $D = t_p/T$ 


## 5 Package Outlines



**Figure 12 PG-DSO36**

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